

Notice of References Cited	Application/Control No. 10/576,212		Applicant(s)/Patent Under Reexamination CHOSA ET AL.	
	Examiner Dwight Alex C. Tejano		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0174219 A1	09-2003	Iijima, Jun	348/231.99
*	B	US-2004/0201692 A1	10-2004	Parulski et al.	348/207.1
*	C	US-2002/0180873 A1	12-2002	Misawa, Takeshi	348/231.6
*	D	US-2001/0041056 A1	11-2001	Tanaka et al.	386/95
*	E	US-2003/0011683 A1	01-2003	Yamasaki et al.	348/207.1
*	F	US-2003/0063304 A1	04-2003	Satomi et al.	358/1.11
*	G	US-2004/0263661 A1	12-2004	Okisu et al.	348/333.02
*	H	US-2005/0110878 A1	05-2005	Dalton, Dan L.	348/231.2
*	I	US-2005/0254099 A1	11-2005	Yoda et al.	358/403
*	J	US-6,229,566 B1	05-2001	Matsumoto et al.	348/231.2
*	K	US-6,977,679 B2	12-2005	Tretter et al.	348/231.2
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.